Search Notes

Application/Control No.	_

09/911,592

Examiner

Shin-Hon Chen

Applicant(s)/Patent under Reexamination

HOEFELMEYER ET AL.

Art Unit

2131

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SEARCH NOT (INCLUDING SEARCH)
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USPAT, PGPUB, DERWENT, JPO, EPO (BRS search)	8/8/2006	S.C.